

**Search Notes**

Application/Control No.

10/724,471

Examiner

James D. Stein

Applicant(s)/Patent under  
Reexamination

ZHONG ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
385	15,47,88 92,130	7/18/2005	JDS
398	82,83	7/18/2005	JDS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	7/18/2005	JDS
IEEE and INPSEC: coupler, thin film, add, drop, multiplex, demultiplex, substrate	7/18/2005	JDS